NATIONAL INSTITUTE OF TECHNOLOGY, TIRUCHIRAPPALLI DEPARTMENT OF ELECTRONICS AND COMMUNICATION ENGINEERING

	COURSE PLAN	– PART I	
Course Title	DIGITAL IMAGE I	PROCESSING	
Course Code	ECOE17	No. of Credits	3
Department	ECE	Faculty	Dr. S. Deivalakshmi
Pre-requisites Course Code	NONE		
Course Coordinator(s) (if, applicable)	-		
Other Course Teacher(s)/Tutor(s) E-mail	Research scholar/ Temporary Faculty	Telephone No.	1 eiva@nitt.edu 0 431-2503321
Course Type	PE & OE		
•To treat the 2D systems a		system design a	and discuss
•To treat the 2D systems a techniques specific to 2D s			
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•To treat the 2D systems a techniques specific to 2D s COURSE OUTCOMES (CO) COURSE OUTCOMES At the end of the course student CO1: analyze the need for in and their properties.	ats will be able to mage transforms, types different techniques ent of images both in age degradation and to miques.	PO 1,2,3	

COURSE PLAN - PART II

COURSE OVERVIEW

To learn and understand the fundamentals of digital image processing, various image Transforms, Image Enhancement Techniques, Image restoration Techniques, image compression and Segmentation Techniques.

COURSE TEACHING AND LEARNING ACTIVITIES

S.No.	Week	Topic	Mode of Delivery
I	1WEEK 22 nd to 26 th July (4 contact hours)	Linearity and space-invariance. PSF, Discrete images and image transforms.	Lecture C & T
2	2 WEEK 29 th July to 2 nd August (4 contact hours)	2-D sampling and reconstruction, Image quantization.	Lecture C & T
3	3 WEEK 5 th to 9 th August (4 contact hours)	2-D transforms and properties	Lecture C & T
4	4 WEEK 12 th to 16 th August (4 contact hours)	Image enhancement-Histogram modelling, equalization and modification.	Lecture C & T
5	5 WEEK 19 th to 23 rd August (4 contact hours)	Image smoothing, Image crispening. Spatial filtering, Replication and zooming.	Lecture C & T
6	6 WEEK 26 th to 30 th August	Generalized cepstrum and Homomorphic filtering.	Lecture C & T
	(4 contact hours)	Assessment 1-20 Marks	Written Test (Descriptive)
7	7 WEEK 2 nd to 6 th September (4 contact hours)	Image restoration-image observation models.	Lecture C & T
8	8 WEEK 27 th to 31 th August (4 contact hours)	Inverse and Wiener filtering. Filtering using image transforms.	Lecture C & T
9	9 WEEK 9th to 13thSeptember (4 contact hours)	Constrained least-square restoration.	Lecture C & T
10	10 WEEK 16 th to 20 th September (4 contact hours)	Generalized inverse, SVD and interactive methods.	Lecture C & T
11	11 WEEK 23 rd to 27 th September	Recursive filtering. Maximum entropy restoration. Bayesian methods	Lecture C & T
	(4 contact hours)	Assessment II-10 Marks	Assignment

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12	12 WEEK 30 th Sep to 4 th October (4 contact hours)	Image data compression -sub sampling, Coarse quantization and frame repetition. Pixel coding -PCM, entropy coding, runlength coding Bit-plane coding.		Lecture C & T
13	13 WEEK 7th t to 11th October (4 contact hours)	Predictive coding. Transform coding of images. Hybrid coding and vector DPCM. Interframe hybrid coding. Assessment III-20 Marks		Lecture C & T
				Written Test (Descriptive)
14	14 WEEK 14 th to 18 th October (4 contact hours)	Image analysis-applications, Spatial and transform features. Edge detection, boundary extraction, AR models and region representation.		Lecture C & T
15	15 WEEK 21 st Oct to 7 th November (8 contact hours)	Moments as features Structure. Morpholand transforms. Texture. Scene detection. Segm	Lecture C & T	
- Alexandra		classification.		
COURS		EXAMINATION- 50 M	Iarks	Written Test (Descriptive)
COURS	END SEMESTER DE ASSESSMENT MET Mode of Assessment	EXAMINATION- 50 M HODS		(Descriptive)
	Assessment I Descriptive Type Examination	EXAMINATION- 50 M	Duration 60 minutes	
.No.	Mode of Assessment Assessment I Descriptive Type	EXAMINATION- 50 M HODS Week/Date	Duration	(Descriptive) % Weightage
5.No. 1	Mode of Assessment Assessment I Descriptive Type Examination (Unit 1 & 2) Assessment II Assignment	EXAMINATION- 50 M HODS Week/Date 4th WEEK of August	Duration	(Descriptive) % Weightage 20
2	Assessment II Assessment III Descriptive Type Examination (Unit 1 & 2) Assessment II Assignment (Unit 1, 2 & 3)	EXAMINATION- 50 M HODS Week/Date 4th WEEK of August 3rd WEEK of September 2nd WEEK of	Duration 60 minutes	(Descriptive) % Weightage 20

ESSENTIAL READINGS: Textbooks, reference books Website addresses, journals, etc

TextBooks

- 1.A.K. Jain, "Fundamentals of Digital Image Processing", PHI,1995
- 2. R.C.Gonzalez& R.E. Woods," Digital Image Processing", (2/e), Pearson, 2002.

ReferenceBooks

- 1. J.C. Russ, "The Image Processing Handbook", (5/e), CRC,2006.
- 2.E.S. Gopi,"Digital Image processing using Matlab", Scitechpublications, 2006
- 3. Recent literatures in Digital Image processing

COURSE EXIT SURVEY (mention the ways in which the feedback about the course is assessed and indicate the attainment also)

- 1. The students through class representative may give their feedback at any time which will be duly addressed.
- 2. Feedback from the students through MIS and class committee meetings.

COURSE POLICY (including plagiarism, academic honesty, attendance, etc.)

CORRESPONDENCE

All the students are advised to come to the class regularly. All the correspondence (schedule of classes/schedule of assignment/course material/any other information regarding this course) will be intimated in the class only.

COMPENSATION ASSESSMENT POLICY

If any student who fails to attend assessment 1 or assessment 2 due to any **genuine reasons**, student is permitted to attend **compensation assessment** for the weightage of 20 % (Including assessment I & assessment 2 Portions)

ATTENDANCE POLICY (A uniform attendance policy as specified below shall be followed)

- > At least 75% attendance in each course is mandatory.
- A maximum of 10% shall be allowed under On Duty (OD) category.
- Students with less than 65% of attendance shall be prevented from writing the final assessment and shall be awarded 'V' grade.

ASSESSMENT

- 1. Attending all the assessments are mandatory for every student.
- 2. Finally every student is expected to score minimum 1/3 rd of the top rank holder (or ½ of class average) of the class (including all assessments) to pass the course. Otherwise student would be declared fail and 'F' grade will be awarded. Further he can take up only FORMATIVE ASSESSMENT.
- 3. Please refer to B.Tech Regulations 2015 for the letter grades and corresponding grades

ACADEMIC DISHONESTY & PLAGIARISM

- Possessing a mobile phone, carrying bits of paper, talking to other students, copying from others during an assessment will be treated as punishable dishonesty.
- > Zero mark to be awarded for the offenders. For copying from another student, both students get the same penalty of zero mark.
- The departmental disciplinary committee including the course faculty member, PAC chairperson and the HoD, as members shall verify the facts of the malpractice and award the punishment if the student is found guilty. The report shall be submitted to the Academic office.

The above policy against academic dishonesty shall be applicable for all the programmes. THE STUDENTS ARE EXPECTED TO FOLLOW INSTITUTE RULES.

ADDITIONAL COURSE INFORMATION

The faculty is available for consultation at times as per the intimation given by the faculty

FOR SENATE'S CONSIDERATION

Course Faculty &, Deiral CC-Chairperson Jacob HOD HOD